

S-Band Radar Transistor

The high power pulsed radar transistor device part number IB2226M80 is designed for S-Band radar systems operating over the instantaneous bandwidth of 2.25-2.55 GHz. While operating in class C mode this common base device supplies a minimum of 80 watts of peak pulse power under the conditions of 200 μ s pulse width and 10% duty cycle. All devices are 100% screened for large signal RF parameters, including power gain compression. Excellent spectral stability into output mismatch over a broad input power range make it ideal for use in reliable high power solid state transmitters.



PRELIMINARY DATA

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Device	Freq (MHz)	P _{out} (W)	P _{out +1} (W)	I _C (A)	RL (dB)	G (dB)	N _C (%)	Δ G (dB)	Drp	VSWR	
										1.5:1	2.1
D1361-1	2250	87	102	3.74	9.2	9.64	61%	0.88	0.10	S	P
	2400	107	112	5.36	13	10.52	53%		0.45	S	P
	2550	91	95	4.93	9.2	9.80	48%		0.40	S	P

VCC=36V, Pulse=200 μ s, 10%

Silicon Bipolar

- Ultra-high f_T

Class C Operation

- High Efficiency

Common Base Configuration

- Single Power Supply

Gold Metal

- Maximum Reliability

Emitter Ballasting

- Optimum Thermal Distribution

Internal Impedance Matching

- Ease of Use
- Ultra-low Loss Design

BeO Package

- Unmatched Thermal Reliability

RF Test Fixture

- Broadband
- Matched to 50 Ω
- Long-term Correlation
- 100% Device RF Screening
- No External Tuning Allowed

US Patent Number

- US 8344809B2

MAXIMUM RATINGS

Screen	Parameter	Symbol	Min	Max	Units	Test Conditions
BD	Collector-Emitter Voltage	V_{CES}	70	--	V	$I_C=20mA$.
BD	Emitter-Base Voltage	V_{EBO}	3.0	--	V	$I_B=5Ma$.
BD	Collector Current, Peak	I_C	--	7.75	A	$PW=PW1, DF=DF1$.
BD	Continuous Power Dissipation, Peak	P_D	--	225	W	$PW=PW1, DF=DF1, T_F=25^{\circ}C$.
BD	Operating Temperature	T_{OP}	-30	+50	$^{\circ}C$	$V_{CC}=tbd V, PW=200\mu s, DF=10\%, TF=30\pm 5^{\circ}C, PIN=13W, F=2.25-2.40-2.55GHz$.
BD	Storage Temperature	T_{STG}	-65	+200	$^{\circ}C$	--

Note Screen 'BD' = parameter qualified By Design.

THERMAL CHARACTERISTICS

Screen	Parameter	Symbol	Min	Max	Units	Test Conditions
BD	Thermal Resistance	$R_{TH(JC)}$	1.0	tbd	$^{\circ}C/W$	$V_{CC}=tbd V, PW=200\mu s, DF=10\%, TF=30\pm 5^{\circ}C, PIN=13W, F=2.25-2.40-2.55GHz$.

Note Screen 'BD' = parameter qualified By Design.

PROCESSING SPECIFICATIONS

Screen	Parameter	Symbol	Min	Max	Units	Test Conditions
100%	DC Wafer Probe	--	--	--	--	Per Integra specification.
Q1	Wafer DC and RF Qualification	--	--	--	--	Per Integra specification.
LM	Wire Bond Strength	--	--	--	--	Line monitor per Integra specification.
100%	Pre-cap visual inspection	--	--	--	--	Per Integra specification.
100%	Gross leak test	--	--	--	--	MIL-STD-750D, Method 1071.6, Test Condition C.

Note Screen 'Q1' = parameter is qualified by assembly and test of 3 pieces minimum per wafer.

Note Screen 'LM' = parameter is qualified by assembly line monitor.

DC ELECTRICAL CHARACTERISTICS

Screen	Parameter	Symbol	Min	Max	Units	Test Conditions
100%	Collector-Emitter Breakdown Voltage	BV_{CES}	70	--	V	$I_C=20mA$.
100%	Zero Base Voltage Collector Leakage Current	I_{CES}	--	3.0	mA	$V_{CE}=30V$.
100%	DC Current Gain	H_{FE}	10	100	--	$V_{CE}=5V, I_C=0.1A, T_F=25\pm 5^{\circ}C$.

RF ELECTRICAL CHARACTERISTICS

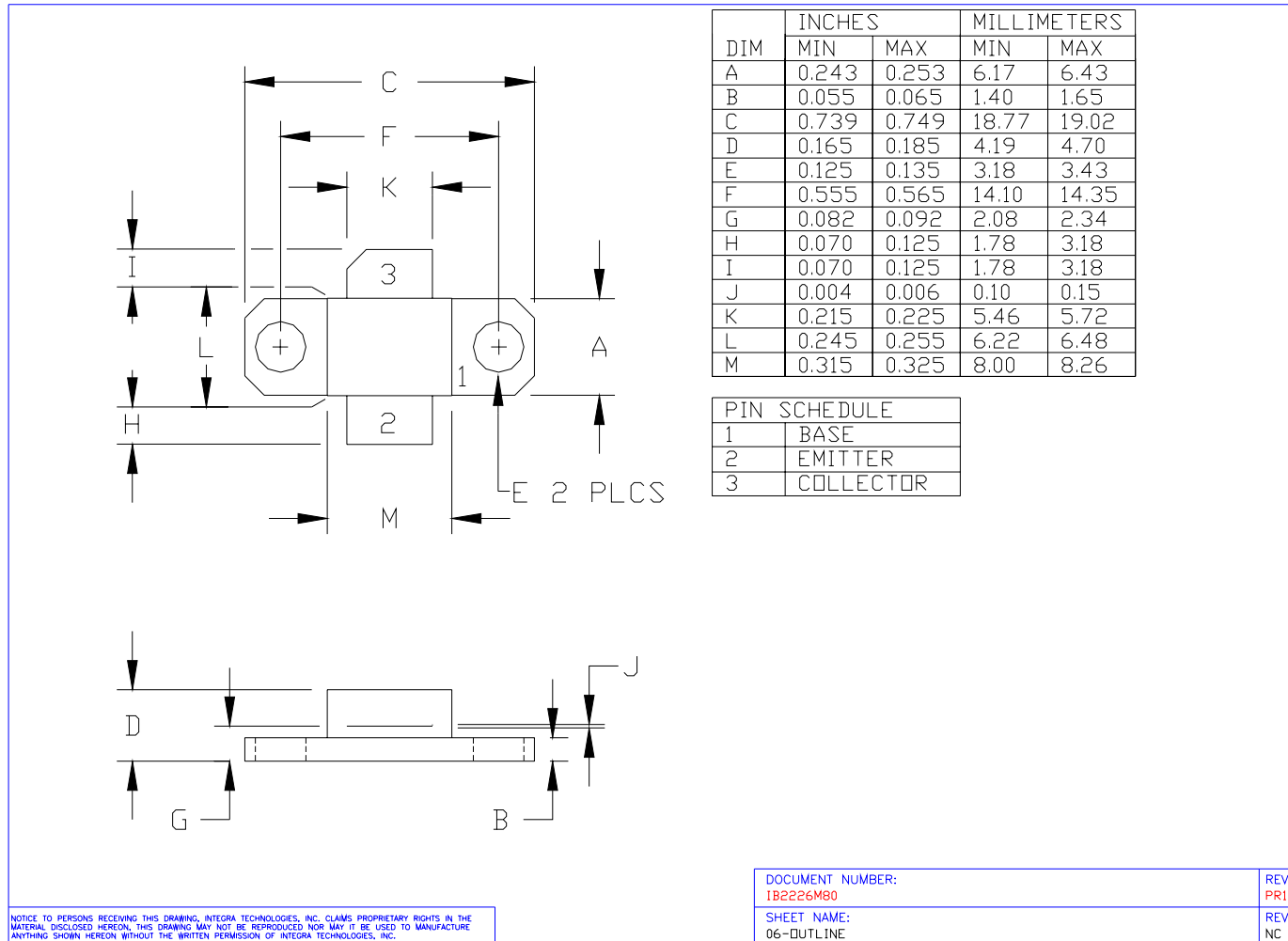
Screen	Parameter	Symbol	Min	Max	Units	Test Conditions
100%	Input Return Loss	IRL	7.0	--	dB	Vcc=38 V, PW=200µs, DF=10%, TF=30±5°C, PIN=13W, F=2.25-2.40-2.55GHz.
100%	Output Power	P _o	80	--	W	Vcc=38 V, PW=200µs, DF=10%, TF=30±5°C, PIN=13W, F=2.25-2.40-2.55GHz.
100%	Power Gain	G _p	7.89	--	dB	Vcc=38 V, PW=200µs, DF=10%, TF=30±5°C, PIN=13W, F=2.25-2.40-2.55GHz.
100%	Collector Efficiency (P _o /I _c /V _{cc})	N _c	38	--	%	Vcc=38 V, PW=200µs, DF=10%, TF=30±5°C, PIN=13W, F=2.25-2.40-2.55GHz.
100%	Pulse Amplitude Droop	D	--	0.7	dB	Vcc=38 V, PW=200µs, DF=10%, TF=30±5°C, PIN=13W, F=2.25-2.40-2.55GHz. Measure at 20 and 180µs.
100%	Gain Flatness	GF		1.3	dB	Vcc=38 V, PW=200µs, DF=10%, TF=30±5°C, PIN=13W, F=2.25-2.40-2.55GHz.
100%	Delta Insertion Phase Variation	d-IP	-30	+30	Deg	Vcc=38 V, PW=200µs, DF=10%, TF=30±5°C, PIN=13W, F=2.25-2.40-2.55GHz.
100%	Stability into 1.5:1	VSWR-S	--	--	--	Vcc=38 V, PW=200µs, DF=10%, TF=30±5°C, PIN=13W, F=2.25-2.40-2.55GHz. Rotate 1:5 output VSWR through 360° phase. No oscillatory or pulse break-up characteristics allowed on detected output pulse.
100%	+1dB Overdrive	OD	Stable	--	--	Vcc=38 V, PW=200µs, DF=10%, TF=30±5°C, PIN=16.4W
100%	2:1 Load Mismatch Tolerance	LMT	--	--	--	Vcc=38 V, PW=200µs, DF=10%, TF=30±5°C, PIN=13W, F=2.25-2.40-2.55GHz. Rotate 2:1 output VSWR through 360° phase. Survival.

RF TEST FIXTURE IMPEDANCE CHARACTERISTICS

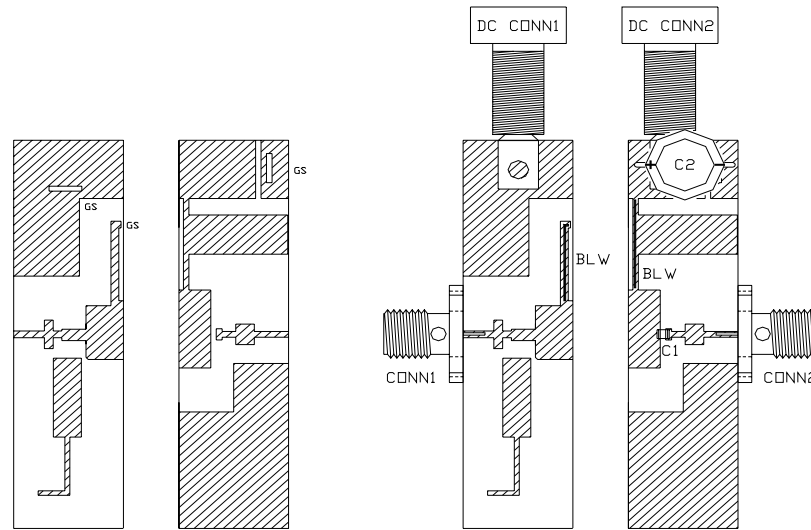
Frequency (MHz)	Z _{IF} (Ω)	Z _{OF} (Ω)
2.25	4.2-j7.1	5.7-j8.4
2.40	3.6-j5.9	5.0-j7.5
2.55	3.3-j4.5	4.7-j6.9

Impedance Definition		
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PACKAGE DIMENSIONAL OUTLINE DRAWING



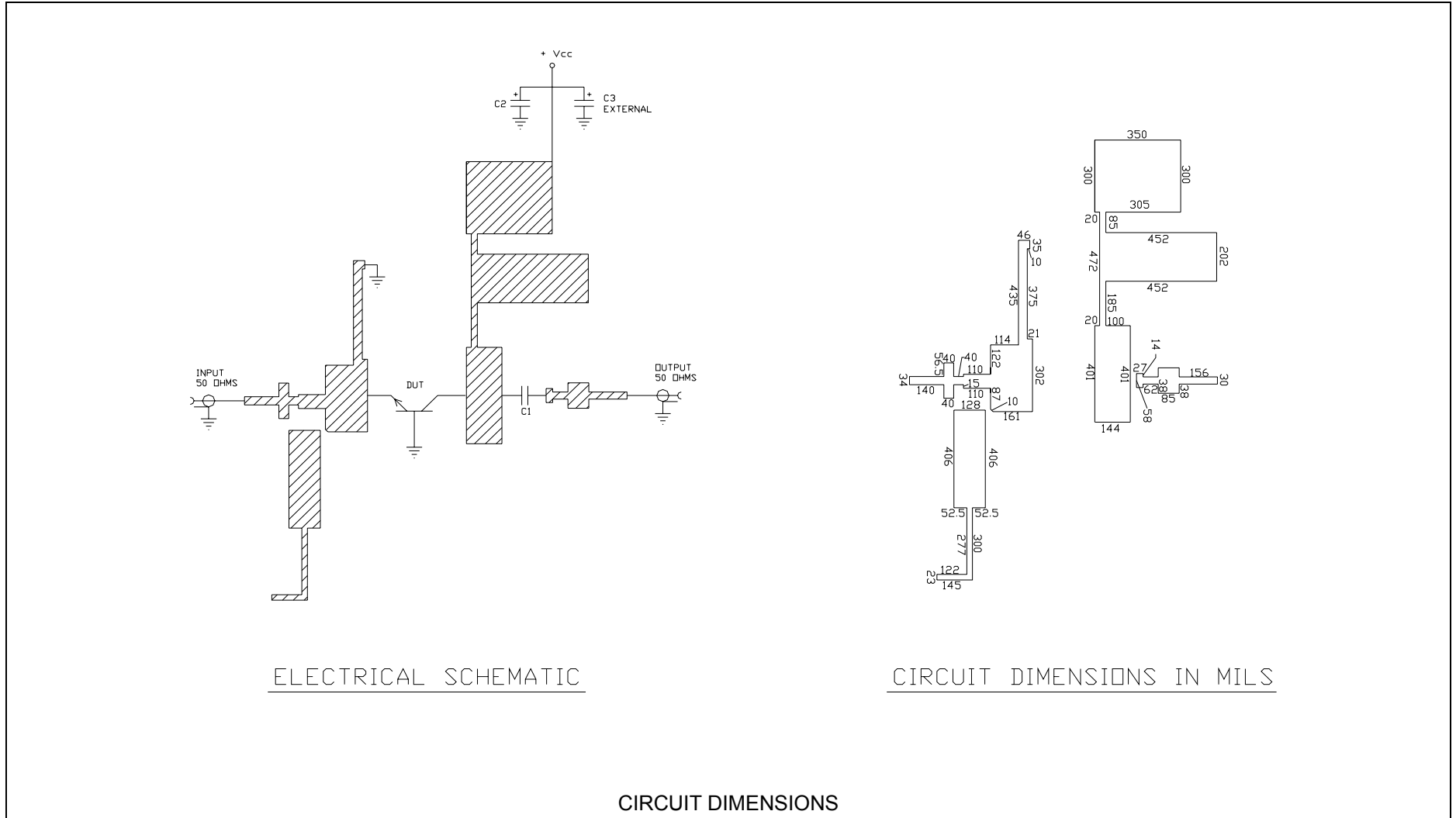
BROADBAND RF TEST FIXTURE



COMPONENT	DESCRIPTION
DUT	TRANSISTOR #IB2226M80, MOUNT HARD TO THE RIGHT
PC BOARD	ROGERS RT6010.2LM 1oz. Cu BOTH SIDES
C1	CHIP CAPACITOR, TYPE ATC100A, 39 pF
C2	ELECTROLYTIC CAPACITOR, 68uF / 63V
C3 - NOT SHOWN	ELECTROLYTIC CAPACITOR, 4700uF / 50V
GS	GROUND SHIM, COPPER, TH=0.001"
CONN1, CONN2	SMA CONNECTOR, TYPE DS #2052-5636-02
INPUT PC BOARD CARRIER	2 INCH BRASS - 01
OUTPUT PC BOARD CARRIER	2 INCH BRASS - 01
TRANSISTOR CARRIER	2 INCH COPPER - 01
TRANSISTOR CLAMP	NORYL CLAMP -01
HEATSINK	2 INCH HEATSINK - 09
DC CONN1	BANANA JACK, BLACK
DC CONN2	BANANA JACK, RED
BLW	BIAS LINE WIRE - COPPER - 0.022" DIA TYPICAL
NOTE	FIXTURE HARDWARE DRAWINGS AVAILABLE ON REQUEST

ASSEMBLY AND PARTS LIST

RF TEST FIXTURE



DEFINITIONS

Data Sheet Status	
Proposed Specification	This data sheet contains proposed specifications.
Preliminary Specification	This data sheet contains specifications based on preliminary measurements and data.
Product Specification	This data sheet contains final product specifications.
Maximum Ratings	
Stress above one or more of the maximum ratings may cause permanent damage to the device. These are maximum ratings only. Operation of the device at these or at any other conditions above those given in the characteristics sections of the specification is not implied. Exposure to maximum values for extended periods of time may affect device reliability.	

WARNING

Product and environmental safety - toxic materials
This product contains beryllium oxide. The product is entirely safe provided that the BeO base is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with general or domestic waste.

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